What is claimed is:

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- 1. A method of forming  $MgB_2$  films in-situ on a substrate comprising the steps:
- (a) depositing boron onto a surface of the substrate in a deposition zone;
  - (b) moving the substrate into a reaction zone containing pressurized gaseous magnesium;
- (c) moving the substrate back into the deposition zone;
  - (d) repeating steps (a)-(c).
  - 2. The method of claim 1, wherein the movement of steps(b) and (c) is produced by rotating the substrate on a platen.
  - 3. The method of claim 2, wherein the platen is rotated at a rate within the range of about 100 rpm to about 500 rpm.
- 4. The method of claim 1, wherein the substrate is
  20 heated to a temperature within the range of about 300°C to about 700°C.
  - 5. The method according to claim 1, wherein the substrate is selected from the group consisting of LSAT,  $LaAlO_3$ , MgO,

SrTiO<sub>3</sub>, r-plane sapphire, c-plane sapphire, m-plane sapphire, yttria-stabilized zirconia (YSZ), silicon carbide, polycrystalline alumina, silicon, and stainless steel.

- 5 6. A MgB<sub>2</sub> film produced by the method of claim 1.
  - 7. The method according to claim 1, wherein the reaction zone is coupled to a heated source of magnesium.
- 10 8. The method according to claim 1, wherein the substrate is a wafer.
  - 9. The method according to claim 1, wherein the substrate is a tape.

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- 10. The method according to claim 1, wherein the method is used to form  $MgB_2$  on a plurality of substrates.
- 11. The method of claim 1, wherein the film of  $MgB_2$  is 20 generated under a pressure of less than  $10^{-6}$  Torr in the deposition zone.
  - 12. The method of claim 1, wherein the  $MgB_2$  film is formed on a single side of the substrate.

- 13. The method of claim 1, wherein the  $MgB_2$  film is formed on two sides of the substrate.
- 5 14. A method of forming a film of  $MgB_2$  in-situ comprising the steps of:

providing a rotatable platen, the platen being rotatable within a housing having a reaction zone and a separate deposition zone;

providing an evaporation cell operatively coupled to the reaction zone, the evaporation cell containing magnesium;

providing a source of boron disposed adjacent to the deposition zone;

providing an electron beam gun aimed at the source of boron;

loading a substrate onto the platen;
rotating the platen;

heating the local environment around the substrate;

heating the evaporation cell so as to produce gaseous

20 magnesium in the reaction zone; and

evaporating the boron with the electron beam gun.

- 15. The method according to claim 14, wherein the local environment around the substrate is heated to a temperature within the range of about 300°C to about 700°C.
- 5 16. The method according to claim 14, wherein the evaporation cell is heated to a temperature of at least 550°C.
- 17. The method according to claim 14, wherein the platen is rotated at a rate within the range of about 100 rpm to about 10 500 rpm.
  - 18. The method according to claim 14, wherein the substrate is selected from the group consisting of LSAT, LaAlO<sub>3</sub>, MgO, SrTiO<sub>3</sub>, r-plane sapphire, c-plane sapphire, m-plane sapphire, yttria-stabilized zirconia (YSZ), silicon carbide, polycrystalline alumina, silicon, and stainless steel.

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tape.

- 19. The method of claim 14, wherein the substrate is a wafer.
- 20. The method of claim 14, wherein the substrate is a

- 21. The method of claim 14, wherein the step of loading the platen comprises loading the platen with a plurality of substrates.
- 5 22. The method of claim 14, wherein the film of  $MgB_2$  is generated under a pressure of less than  $10^{-6}$  Torr in the deposition zone.
- 23. The method of claim 14, wherein a film of  $MgB_2$  is 10 formed on a single side of the substrate.
  - 24. The method of claim 14, further comprising the steps of removing the substrate from the platen; turning the substrate over;
- loading the substrate onto the platen; rotating the platen;

heating the local environment around the substrate;

heating the evaporation cell so as to produce pressurized gaseous magnesium in the reaction zone; and

- 20 evaporating the boron with the electron beam gun.
  - 25. A MgB<sub>2</sub> film produced by the method of claim 14.

- 26. A method of forming a superconducting film of a known superconducting compound in-situ on a substrate comprising the steps:
- (a) depositing one or more elements of the superconductor onto a surface of the substrate in a deposition zone;
  - (b) heating a non-gaseous element of the superconductor so as to produce a pressurized gaseous phase of the element inside a reaction zone;
- (c) moving the substrate into the reaction zone containing the pressurized gaseous element;
  - (d) moving the substrate back into the deposition zone; and
    - (e) repeating steps (a)-(d).
- 15 27. The method of claim 26, wherein the superconducting film is a superconductor selected from the group consisting of magnesium diboride, YBCO, BSCCO, TBCCO, and HBCCO.
- 28. A method of forming a film of a known compound *in-situ*20 on a substrate comprising the steps:
  - (a) depositing one or more elements of the compound onto a surface of the substrate in a deposition zone;

- (b) heating a non-gaseous element of the compound so as to produce a pressurized gaseous phase of the element inside a reaction zone;
- (c) moving the substrate into the reaction zone containing the pressurized gaseous element;
  - (d) moving the substrate back into the deposition zone; and
    - (e) repeating steps (a)-(d).
- 10 29. The method of claim 28, wherein the compound is a superconductor.